

N-Channel Silicon Carbide MOSFET

Rev.01 - 24 November 2023

Product data sheet

alogen-Free

ead-Free

1. General description

Silicon Carbide MOSFET in a TO263-7L plastic package, designed for high frequency, high efficiency systems.

2. Features and benefits

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- Low on-resistance
 - Fast switching speed
 - 0V turn-off gate voltage for simple gate drive
 - 100% UIS Tested
 - · Easy to parallel
 - Controllable dV/dt for optimized EMI
 - Reduced cooling requirements
 - RoHS compliant

3. Applications

- Switch Mode Power Supplies
- UPS
- Solar string inverter and solar optimizer
- EV Charger
- Motor Drives

4. Quick reference data

Table 1. Qu	lick reference data						
Symbol	Parameter	Conditions	Notes		Values		Unit
Absolute	maximum rating						
V _{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C			1200		V
I _D	drain current	V _{GS} = 18 V; T _{mb} = 25 °C			154.4		А
P _{tot}	total power dissipation	T _{mb} = 25 °C, T _j = 175 °C			789		W
Tj	junction temperature			-55 to 175		°C	
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static cha	aracteristics						
$R_{\text{DS(on)}}$	drain-source on-state resistance	V _{GS} = 15 V; I _D = 50 A; T _j = 25 °C		-	20	-	mΩ
Dynamic	characteristics					·	
Q _{G(tot)}	total gate charge	$I_{D} = 50 \text{ A}; V_{DS} = 800 \text{ V}; V_{GS} = -4 \text{ V}/18 \text{ V};$		-	215	-	nC
Q_{GD}	gate-drain charge	T _j = 25 °C		-	32	-	nC
Source-d	rain diode						
Q _r	recovered charge	I_{SD} = 50 A; di/dt = 500 A/µs; V _{DS} = 400 V; T _j = 25 °C		-	276	-	nC

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5. Pinning information

Table	2	Pinning	information
Table	Ζ.	Pinning	mormation

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate	mb	D
2	SS	source sense		$\overset{\circ}{\frown}$
3-7	S	source		G_(IETA)
mb	D	mounting base; connected to drain	TO263-7L	sym301 S

6. Ordering information

Table 3. Ordering information								
Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date		
WNSC2M20120B7	TO263-7L	WNSC2M20120B76J	Reel	800	TO263P-7L	12-Jun-2023		

7. Marking

Table 4. Marking codes		
Type number	Marking codes	
WNSC2M20120B7	WNSC2M 20120B7	

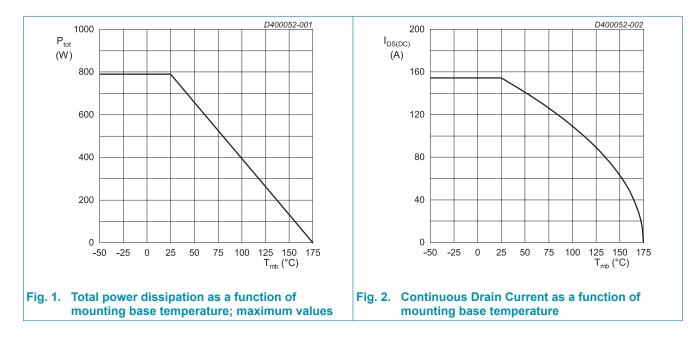
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8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Values	Unit
V _{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C		1200	V
$V_{GS,max}$	gate-source voltage			-12 to 24	V
$V_{\text{GS,op}}$	gate-source voltage			-4 to 18	V
P _{tot}	total power dissipation	T _{mb} = 25 °C, T _j = 175 °C		789	W
I _D	drain current	V _{GS} = 18 V; T _{mb} = 25 °C		154.4	А
		V _{GS} = 18 V; T _{mb} = 100 °C		109.2	А
I _{DM}	peak drain current	pulse width t_p limited by T_{jmax}	Fig.17	300	А
ls	continuous diode current	V _{GS} = -4 V; T _{mb} = 25 °C		107.1	А
I _{SM}	pulse diode current	V_{GS} = -4 V; pulse width t_p limited by T_{jmax}		300	A
E _{as}	single pulse drain-to- source avalanche	I_{AS} = 30 A; L = 1 mH; V _{DD} = 100 V; T _j = 25 °C		450	mJ
T _{stg}	storage temperature			-55 to 175	°C
Tj	junction temperature			-55 to 175	°C
T _{sld(M)}	peak soldering temperature			260	°C

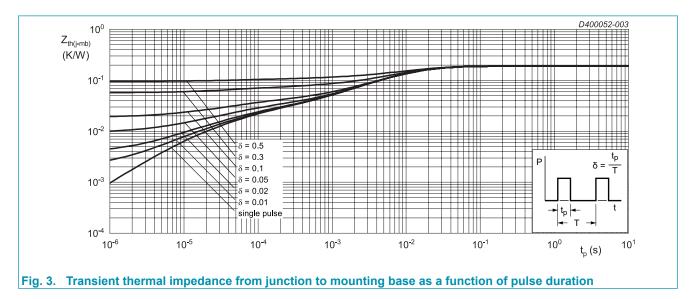


9. Thermal & Mechanical characteristics

Table 6. Thermal & Mechanical characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base			-	0.19	-	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	in free air		-	40	-	K/W

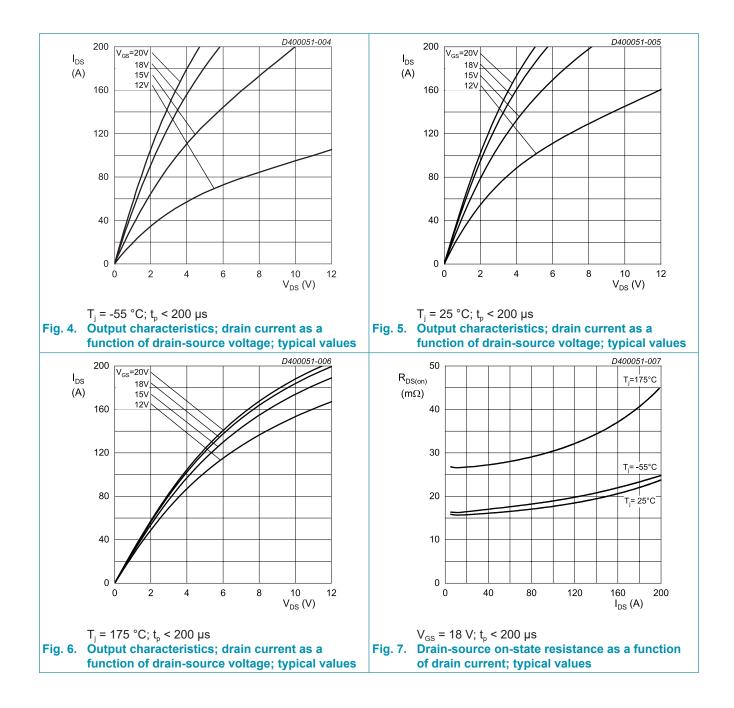
Note: Device is ESD sensitive. Handling precautions are recommanded.

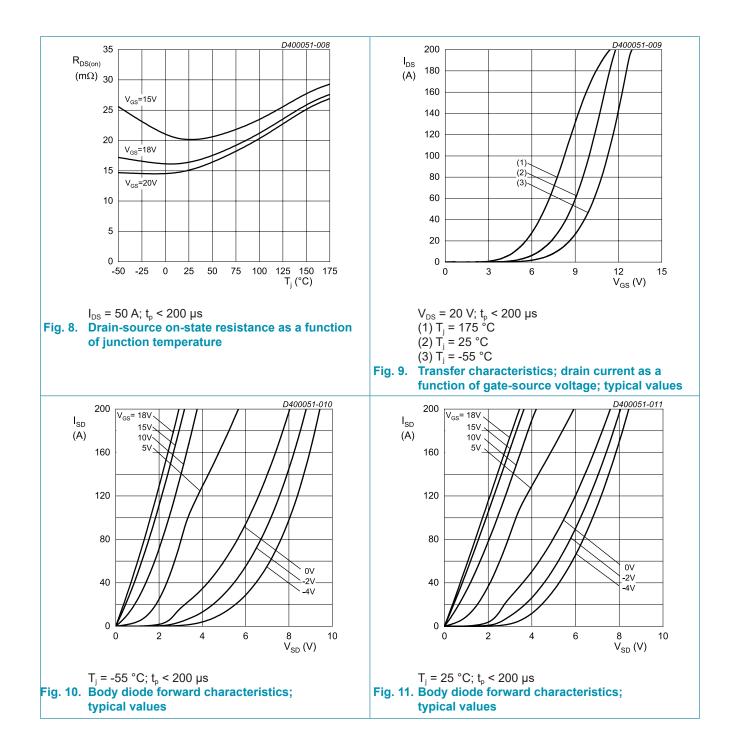


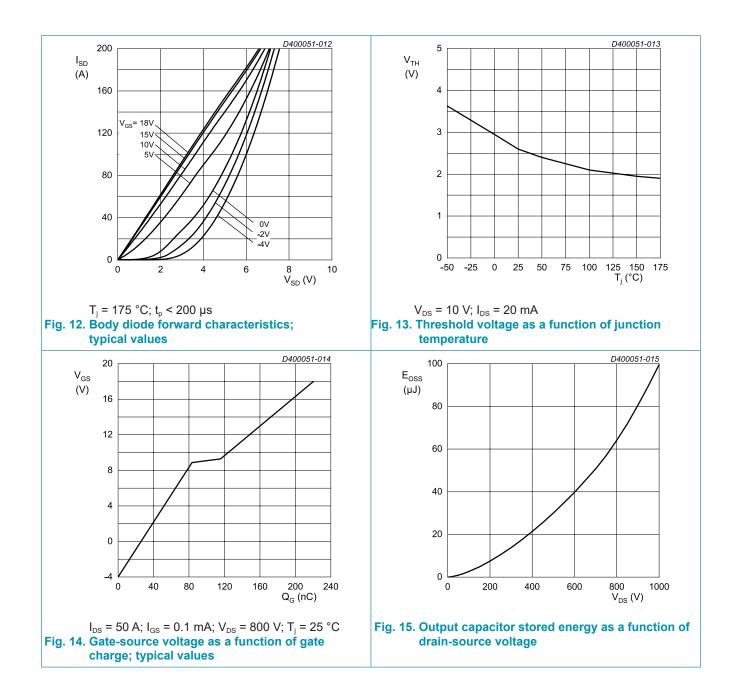
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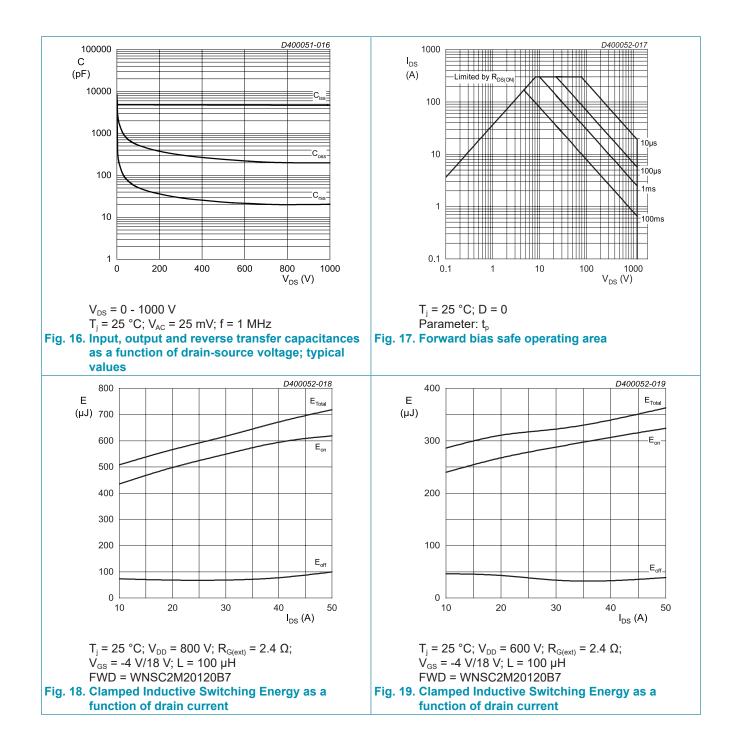
10. Characteristics

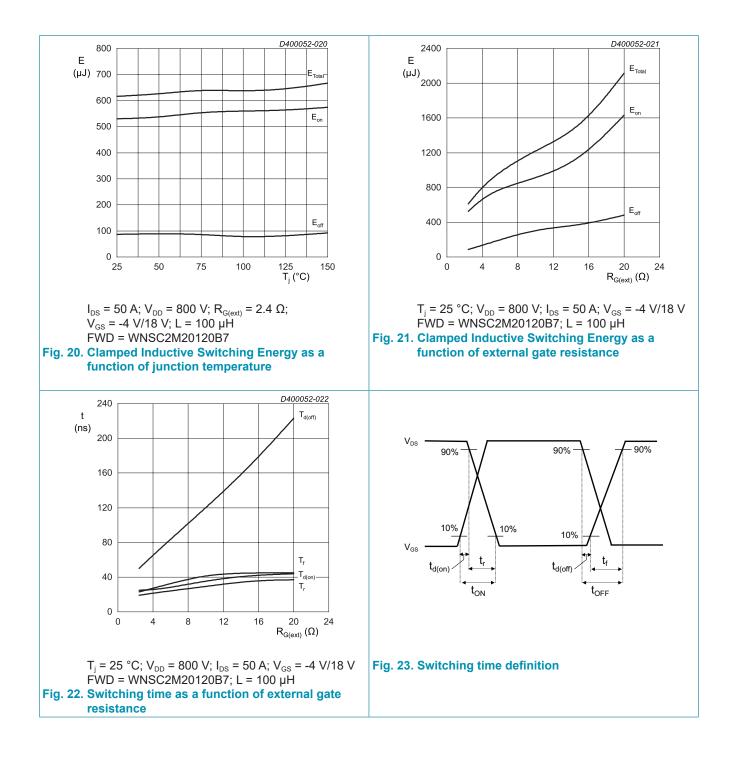
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
	aracteristics	Conditions	NULES	IVIIII	קעי	INIAA	
V _{(BR)DSS}	drain-source breakdown voltage	I_{D} = 100 µA; V_{GS} = 0 V; T_{j} = 25 °C		1200	-	-	V
V _{GS(th)}	gate-source threshold	I _D = 20 mA; V _{DS} = 10 V; T _j = 25 °C		1.9	2.6	3.5	V
	voltage	I _D = 20 mA; V _{DS} = 10 V; T _j = 175 °C		-	1.9	-	V
l _{DSS} di	drain leakage current	V _{DS} = 1200 V; V _{GS} = 0 V; T _j = 25 °C		-	0.2	100	μA
		V _{DS} = 1200 V; V _{GS} = 0 V; T _j = 175 °C		-	2	-	μA
I _{GSS}	gate leakage current	V _{GS} = 24 V; V _{DS} = 0 V; T _j = 25 °C		-	10	100	nA
		V _{GS} = -12 V; V _{DS} = 0 V; T _j = 25 °C		-	10	100	nA
R _{DS(on)}	drain-source on-state	V _{GS} = 15 V; I _D = 50 A; T _j = 25 °C		-	20	-	mΩ
	resistance	V _{GS} = 18 V; I _D = 50 A; T _j = 25 °C		-	16.3	29	mΩ
		V _{GS} = 18 V; I _D = 50 A; T _j = 175 °C		-	27.6	-	mΩ
R _G	gate resistance	f = 1 MHz; T _j = 25 °C		-	0.6	-	Ω
g _{fs}	transconductance	V _{DS} = 20 V; I _D = 50 A; T _j = 25 °C		-	32	-	S
Dynamic	characteristics						
Q _{G(tot)}	total gate charge	$I_{D} = 50 \text{ A}; V_{DS} = 800 \text{ V}; V_{GS} = -4 \text{ V}/18 \text{ V};$		-	215	-	nC
Q _{GS}	gate-source charge	$T_j = 25 \ ^{\circ}C$		-	83	-	nC
Q _{GD}	gate-drain charge			-	32	-	nC
C _{iss}	input capacitance	V _{DS} = 1000 V; V _{GS} = 0 V; f = 1 MHz;		-	4701	-	pF
C _{oss}	output capacitance	$T_j = 25 \ ^{\circ}C$		-	199	-	pF
C _{rss}	reverse transfer capacitance			-	20	-	pF
E _{oss}	Coss stored energy			-	99.5	-	μJ
t _{d(on)}	turn-on delay time	V_{DS} = 800 V; V_{GS} = -4 V/18 V; $R_{G(ext)}$ = 2.4		-	25	-	ns
t _r	rise time	Ω; $I_D = 50$ A; L = 100 µH; $T_j = 25°$ C		-	19	-	ns
t _{d(off)}	turn-off delay time			-	50	-	ns
t _f	fall time			-	23	-	ns
Eon	turn-on energy (Body Diode FWD)		Fig.20	-	526	-	μJ
E _{off}	turn-off energy (Body Diode FWD)		Fig.20	-	85	-	μJ
Source-d	rain diode						
V _{SD}	source-drain voltage	V_{GS} = 0 V; I_{SD} = 25 A; T_{j} = 25 °C		-	2.9	-	V
		V _{GS} = -4 V; I _{SD} = 25 A; T _j = 25 °C		-	4.7	-	V
		V _{GS} = -4 V; I _{SD} = 25 A; T _j = 175 °C		-	4.1	-	V
t _{rr}	reverse recovery time	$I_{SD} = 50 \text{ A}; \text{ di/dt} = 500 \text{ A/}\mu\text{s}; \text{ V}_{DS} = 400 \text{ V};$		-	54	-	ns
Q _r	recovered charge	T _j = 25 °C		-	276	-	nC
I _{rrm}	reverse recovery current			-	9	-	Α





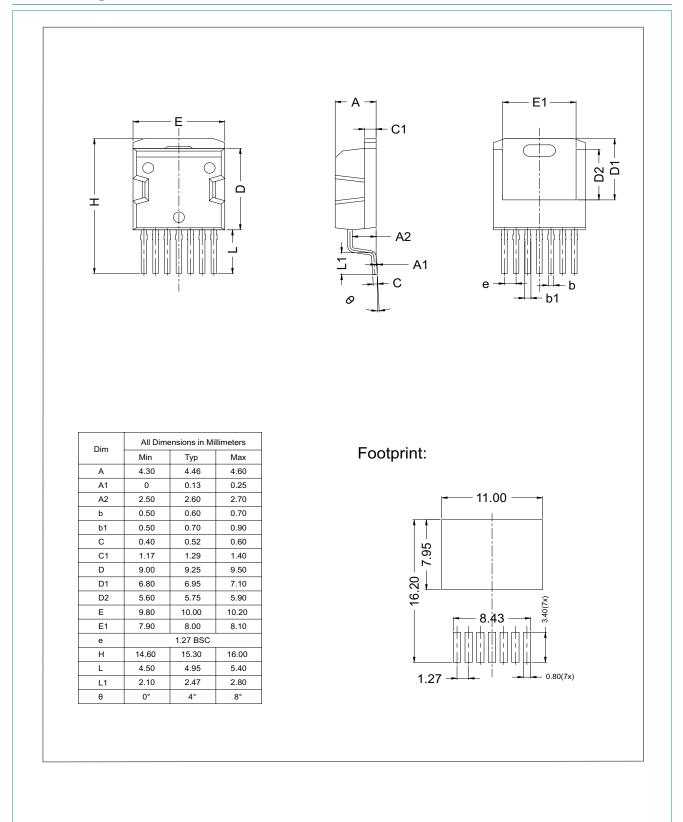






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11. Package outline



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12. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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- [2] The term 'short data sheet' is explained in section "Definitions".
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